AMENDMENT TO THE CLAIMS:

1. (Original) A pattern formation material for electron beam lithography, comprising an alkali-soluble resin and a photoacid generator which generates an acid when irradiated with an electron beam, wherein

said pattern formation material further comprises first and second dissolution inhibiting groups each of which has a capacity of inhibiting dissolution of said alkalisoluble resin in an alkali solution and loses the capacity upon application of an acid, said first dissolution inhibiting group increasing a sensitivity of said pattern formation material when left to stand in a vacuum after irradiated with an electron beam, and said second dissolution inhibiting group decreasing the sensitivity of said pattern formation material when left to stand in a vacuum after irradiated with an electron beam, and

a ratio of said first dissolution inhibiting group to said second dissolution inhibiting group is adjusted such that a size of an alkali-soluble portion, which is a portion made soluble in said alkali solution when said pattern formation material is irradiated with an electron beam, is substantially held constant independently of a standing time in a vacuum.

- 2. (Original) A material according to claim 1, wherein at least one of said first and second dissolution inhibiting groups is a functional group which modifies said alkali-soluble resin.
- 3. (Original) A material according to claim 1, wherein said pattern formation material further comprises a dissolution inhibitor, and at least one of said first

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1300 I Street, NW Washington, DC 20005 202.408.4000 Fax 202.408.4400 www.finnegan.com and second dissolution inhibiting groups is a functional group which forms said dissolution inhibitor.

- 4. (Original) A material according to claim 1, wherein said first dissolution inhibiting group is a t-butoxycarbonyloxy group.
- 5. (Original) A material according to clam 1, wherein said second dissolution inhibiting group is an acetal-type functional group.
- 6. (Original) A material according to claim 1, wherein the ratio of said first dissolution inhibiting group to said second dissolution inhibiting group is adjusted such that a difference between the size of said alkali-soluble portion immediately after irradiated with an electron beam in a vacuum and the size of said alkali-soluble beam in a vacuum and the size of said alkali-soluble portion left to stand for 10 hr in a vacuum after irradiated with an electron beam is not more than +/- 5 nm.

Claims 7 - 19 (Canceled)

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